Application/Control No. Applicant(s)/Patent Under Reexamination 10/615,622 VOOK ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Gevell Selby 2622 **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY * Ohta, Seiya US-5,895,129 04-1999 396/79 Α * 04-2001 Hase, Hiroyuki US-6,212,021 359/820 В * US-2002/0101531 08-2002 Kaneda, Naoya 348/347 С US-D US-E US-F US-G US-Н US-1 US-J US-Κ US-L US-М FOREIGN PATENT DOCUMENTS **Document Number** Date Classification Country Name Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧ W Х

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.